

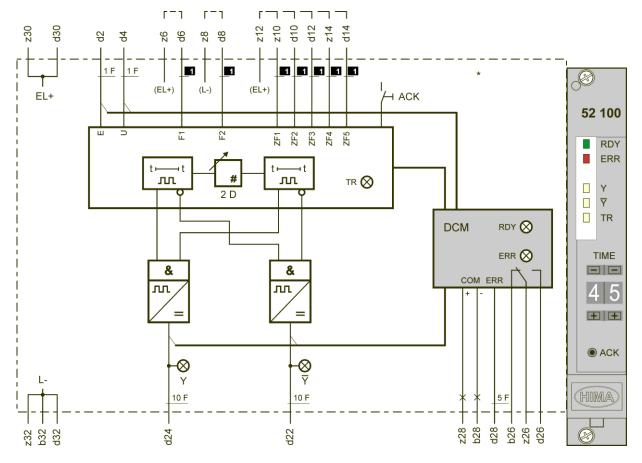


# 52 100: Time Delay Module

# Safety-related

The module can be used for the following applications:

- With 1001 wiring in accordance with IEC 61508 for SIL 3 applications.
- With redundant wiring (1002 or 2003) for SIL 4 applications.



Outputs are short-circuit-proof

Connection to EL+ or L-, depending on the function

Figure 1: Block Diagram

The maximum cable length within the control cabinet between the 52 100 time delay module and other modules may not exceed 3 m.

Selection	Time range	range Resolution		
ZF1	0.19.9 s	0.1 s		
ZF2	199 s	1 s		
ZF3	10990 s	10 s		
ZF4	605 940 s	60 s		
ZF5	60059 400 s	600 s		

Table 1: Time Range Settings

Time accuracy < 0.1 % of the setpoint

Fundamental deviation -10...+90 ms

The 1-signals at the outputs Y and  $\bar{Y}$  do not overlap (gap of approx. 20 ms).

Switching time Y approx. 45 ms

Y approx. 25 ms

Reset time Y approx. 20 ms

Y approx. 40 ms

Operating data 24 VDC / 100 mA

Space requirement 3 RU, 4 HP

The safety-related time delay module is composed of a two-channel safety-related processor system. Each processor system processes the specified time function and performs self-tests and monitoring. The module is initialized after the supply voltage was connected or by pressing the ACK key (after a fault). After initialization, the safety-related outputs Y and  $\bar{Y}$  are in proper working condition.

To configure the time, connect EL+ to one of the time factor inputs ZF1...ZF5 and set the two-decade pre-selector on the front plate. The delay or pulse time t<sub>d</sub> is calculated as follows:

td = Resolution x value of the decade selector

During operation, no changes to the switching input (U) with occurring pulses, to the function inputs (F1, F2) or to the time factor inputs (ZF1...ZF5) are permitted. When the settings are changed for the decade selector (LED TR is blinking), press the *ACK* key within 60 s or reset the parameter to its previous value to prevent the module from entering the error state. A time change is only adopted after a new activation.

If an internal error or component fault occurs, the two outputs Y and  $\bar{Y}$  are switched to 0 (no output signal), and the ERR output is set to 1. While the time is running, the time can tend to infinity for function 0-1 delay, whereas for function 1-0 delay and for pulsed functions, it can tend to zero.

# **Functions**

The following wiring (control signal at input E) can be used to achieve the functions:

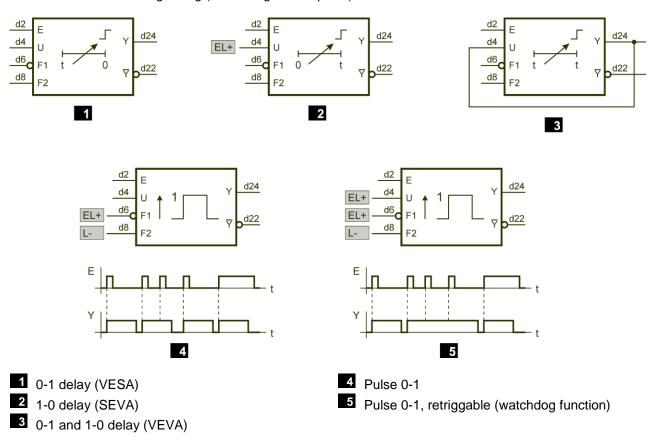


Figure 2: Functions

# Description of the LEDs

Ȳ, Y (yellow)
 Indicators for the Ȳ and Y outputs
 TR (yellow)
 Time span (continuous light)
 Initialization (continuous light)
 Time change (blinking light)

All the module functions are monitored by a microcontroller.

This also applies to functions that are not detected by the safety-related part since failures may cause the module to enter the safe state (e.g., component failure at the control input E)

If a malfunction occurs, the ERR LED is lit, output d28 is on 1-signal and relay contact z26-d26 opens. Output z28-b28 is intended for connecting to the communication module, e.g., for transferring data to a distributed control system (DCS).

RDY (Ready) indicates the applied voltage (≥ 20 V).

#### **Notes**

For the function 1-0 delay (SEVA), a running time can be reset to zero (i.e., time expired) via a short interruption of EL+ at the d4 input (e.g., using a key):

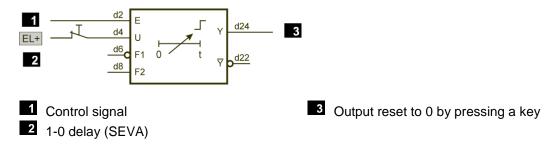


Figure 3: 1-0 Delay (SEVA)

#### **Notices**

To protect the time settings, the module must be configured such that only authorized users may modify them.

To obtain the safety time, add 75 ms (maximum fault detection and response time) to the selected delay time.

# **Function Requirements**

Name	Function	Reliability
0-1 delay (VESA)	Delayed on, immediately off	For applications in which the configured time may be increased but not decreased.
1-0 delay (SEVA)	Immediately on, de- layed off	For applications in which the configured time may be decreased but not increased.
0-1 and 1-0 delay (VEVA)	Delayed on, immediately off	When switching on: For applications in which the configured time may be increased but not decreased.  When switching off: For applications in which the configured time may be decreased but not increased.
Pulse	When the input signal changes from 0 to 1	For applications in which the configured time may be decreased but not increased.

Table 2: Requirements for Using the Functions

# **Proof Test**

The 52 100 module must be subject to a proof test in intervals of 10 years.

# Redundant 1002 Wiring for SIL 4 Applications

Two 52 100 time delay modules are redundantly connected via their digital inputs. Both modules use the same delay setting and their outputs are connected via AND gate (42 110 module). If one of the two 52 100 time delay modules fails, the outputs are set to the safe state.

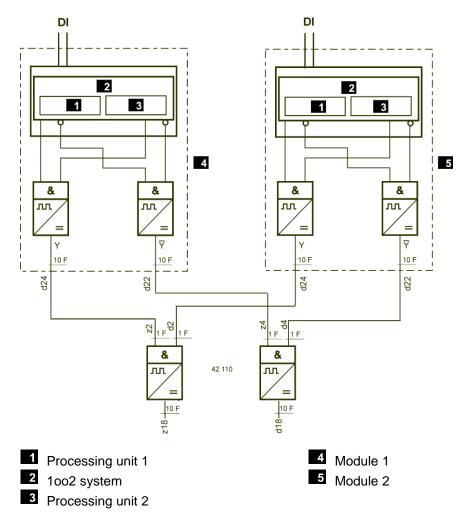


Figure 4: Redundant 1002 Wiring for SIL 4 Applications

# Redundant 2003 Wiring for SIL 4 Applications

Three 52 100 time delay modules are redundantly connected via their digital inputs. The three modules use the same limit value setting and their outputs are connected through a 2003 voting element (e.g., the 42 500 module). If two of the 52 100 modules fail, the outputs are set to the safe state.

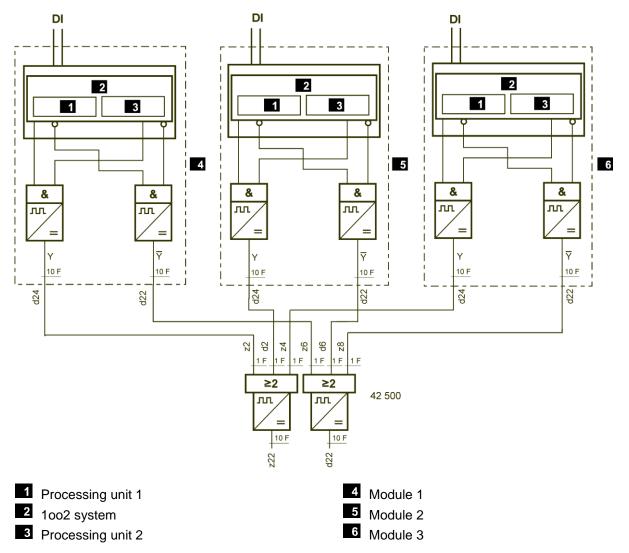


Figure 5: Redundant 2003 Wiring for SIL 4 Applications

# Communication via Modbus

Read Variables

Type BOOL: Function code 1
Type WORD: Function code 3

Events: Function codes 65, 66, 67

Relative address	Data type	Value	Description	Relative event no.
0	WORD	E1 H	Module type 52 100	
1	BOOL	0	None	
2	BOOL	1	Module removed	
3	BOOL	1	Communication with module not ok	
4	BOOL	1	Module in slot, communication ok	
5	BOOL	1	Operating voltage too low, no RDY	
6	BOOL	1	Module fault, ERR	
78	BOOL	0	None	
9	BOOL	1	1-signal on control input d2	0
10	BOOL	1	1-signal on switching input d4	1
1124	BOOL	0	None	
25	WORD	065 535	Residual time in seconds	
26	BOOL	1	1-signal at output d22   Ÿ	24
27	BOOL	1	1-signal at output d24 Y	25
2833	BOOL	0	None	

Table 3: All Specifications of the 52 100 Module

Value: 0 always has the opposite meaning

H: Hexadecimal value

Absolute address: A = p \* 256 + relative addressAbsolute event no.: E = (p - 1) \* 32 + relative event no.

p = Slot no. in the subrack

# Reading of All Variables

Function code 3, 84 WORDS

Starting with address 2000 H, 3000 H or 4000 H

	WORD 0 (16-bit)		WORD 1 (16-bit)		WORD 2 (16-bit)	WORD 3	3 (16-bit)
Relative address	0	81	2417	169	25		3326
Data	Module type	Module status	None	None	Residual time in s	None	Outputs

For error-free data transfer, all 84 WORDS must be read. This ensures that the variables of all the modules within a subrack are transferred. 0 is transferred for unused module slots.

# Communication via PROFIBUS DP

# Read Variables

Relative addresses of WORD and BYTE type

Module state, signals at the outputs

WORD	Bit	BYTE	Bit	Value	Description	
	07	0	07	E1 H	Module type 52 100	
	8		0	0	None	
	9		1	1	Module removed	
	10		2	1	Communication with module not ok	
0	11	1	3	1	Module in slot, communication ok	
	12		4	1	Operating voltage too low, no RDY	
	13		5	1	Module fault, ERR	
	14		6	0	None	
	15		7	0	None	
	0		0	1	1-signal on control input d2	
1	1	2	1	1	1-signal on switching input d4	
	27		27	0	None	
	815	3	07	0	None	
2	815	4	07	0127	Residual time (high byte) in seconds	
	07	5	07	0127	Residual time (low byte) in seconds	
	0		0	1	1-signal at output d24 Ÿ	
3	1	6	1	1	1-signal at output d22 Y	
	27		27	0	None	
	815	7	07	0	None	

Table 4: Module State, Signals at the Outputs

Value: 0 always has the opposite meaning

H: Hexadecimal value

Absolute address WORD: W = 4 \* (p - 1) + relative addressAbsolute address BYTE: B = 8 \* (p - 1) + relative address

p = Slot no. in the subrack

# Safety Parameters

The following table specifies the PFD, PFH and SFF values for a mono 52 100 module (1001) and for the redundant wiring variants (1002 and 2003).

Parameter	1001	1002	2003	
PFD	8.333359*10 <sup>-6</sup> /h	6.627255*10 <sup>-7</sup> /h	6.656553*10 <sup>-7</sup> /h	
PFH	7.546215*10 <sup>-10</sup> /h	7.198501*10 <sup>-10</sup> /h	7.290996*10 <sup>-10</sup> /h	
SFF	99.764 %	99.7647 %	99.7647 %	
Proof test interval		10 years		